

**SWITCHING
N-CHANNEL POWER MOS FET****DESCRIPTION**

The 2SK3458 is N-channel DMOS FET device that features a low gate charge and excellent switching characteristics, designed for high voltage applications such as switching power supply.

FEATURES

- Low gate charge
 $Q_G = 25 \text{ nC TYP. (} V_{DD} = 450 \text{ V, } V_{GS} = 10 \text{ V, } I_D = 6.0 \text{ A)}$
- Gate voltage rating $\pm 30 \text{ V}$
- Low on-state resistance
 $R_{DS(on)} = 2.2 \text{ } \Omega \text{ MAX. (} V_{GS} = 10 \text{ V, } I_D = 3.0 \text{ A)}$
- Avalanche capability ratings
- Surface mount package available

ORDERING INFORMATION

| PART NUMBER | PACKAGE |
|-------------|----------|
| 2SK3458 | TO-220AB |
| 2SK3458-S | TO-262 |
| 2SK3458-ZK | TO-263 |

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$)

| | | | |
|--|----------------|------------------------|------------------|
| Drain to Source Voltage ($V_{GS} = 0 \text{ V}$) | V_{DSS} | 800 | V |
| Gate to Source Voltage ($V_{DS} = 0 \text{ V}$) | V_{GSS} | ± 30 | V |
| Drain Current (DC) ($T_C = 25^\circ\text{C}$) | $I_{D(DC)}$ | ± 6.0 | A |
| Drain Current (pulse) ^{Note1} | $I_{D(pulse)}$ | ± 24 | A |
| Total Power Dissipation ($T_A = 25^\circ\text{C}$) | P_{T1} | 1.5 | W |
| Total Power Dissipation ($T_C = 25^\circ\text{C}$) | P_{T2} | 100 | W |
| Channel Temperature | T_{ch} | 150 | $^\circ\text{C}$ |
| Storage Temperature | T_{stg} | $-55 \text{ to } +150$ | $^\circ\text{C}$ |
| Single Avalanche Current ^{Note2} | I_{AS} | 6.0 | A |
| Single Avalanche Energy ^{Note2} | E_{AS} | 66.5 | mJ |

Notes 1. $PW \leq 10 \text{ } \mu\text{s}$, Duty Cycle $\leq 1\%$

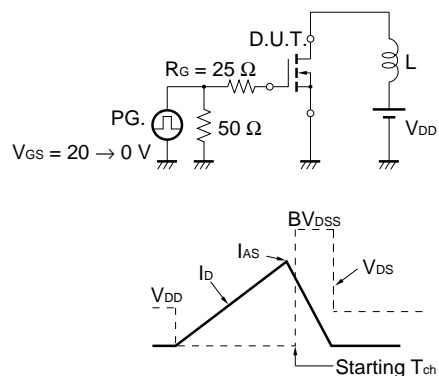
2. Starting $T_{ch} = 25^\circ\text{C}$, $V_{DD} = 150 \text{ V}$, $R_G = 25 \text{ } \Omega$, $V_{GS} = 20 \rightarrow 0 \text{ V}$

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 Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

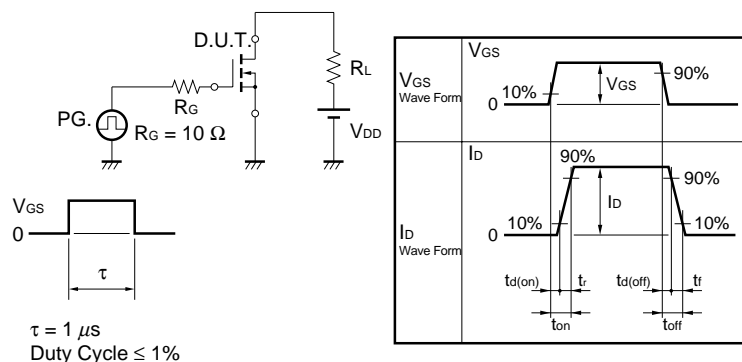
ELECTRICAL CHARACTERISTICS (T_A = 25°C)

| CHARACTERISTICS | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-------------------------------------|----------------------|---|------|------|------|------|
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} = 800 V, V _{GS} = 0 V | | | 100 | μA |
| Gate Leakage Current | I _{GSS} | V _{GS} = ±30 V, V _{DS} = 0 V | | | ±100 | nA |
| Gate Cut-off Voltage | V _{GS(off)} | V _{DS} = 10 V, I _D = 1 mA | 2.5 | | 3.5 | V |
| Forward Transfer Admittance | y _{fs} | V _{DS} = 10 V, I _D = 3.0 A | 2.0 | | | S |
| Drain to Source On-state Resistance | R _{DS(on)} | V _{GS} = 10 V, I _D = 3.0 A | | 1.8 | 2.2 | Ω |
| Input Capacitance | C _{iss} | V _{DS} = 10 V | | 1220 | | pF |
| Output Capacitance | C _{oss} | V _{GS} = 0 V | | 170 | | pF |
| Reverse Transfer Capacitance | C _{rss} | f = 1 MHz | | 16 | | pF |
| Turn-on Delay Time | t _{d(on)} | V _{DD} = 150 V, I _D = 3.0 A | | 17 | | ns |
| Rise Time | t _r | V _{GS} = 10 V | | 7 | | ns |
| Turn-off Delay Time | t _{d(off)} | R _G = 10 Ω | | 43 | | ns |
| Fall Time | t _f | | | 11 | | ns |
| Total Gate Charge | Q _G | V _{DD} = 450 V | | 25 | | nC |
| Gate to Source Charge | Q _{GS} | V _{GS} = 10 V | | 6 | | nC |
| Gate to Drain Charge | Q _{GD} | I _D = 6.0 A | | 10 | | nC |
| Body Diode Forward Voltage | V _{F(S-D)} | I _F = 6.0 A, V _{GS} = 0 V | | 1.0 | | V |
| Reverse Recovery Time | t _{rr} | I _F = 6.0 A, V _{GS} = 0 V | | 1490 | | ns |
| Reverse Recovery Charge | Q _{rr} | di/dt = 50 A/μs | | 7.5 | | μC |

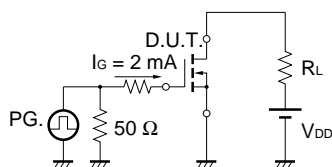
TEST CIRCUIT 1 AVALANCHE CAPABILITY



TEST CIRCUIT 2 SWITCHING TIME

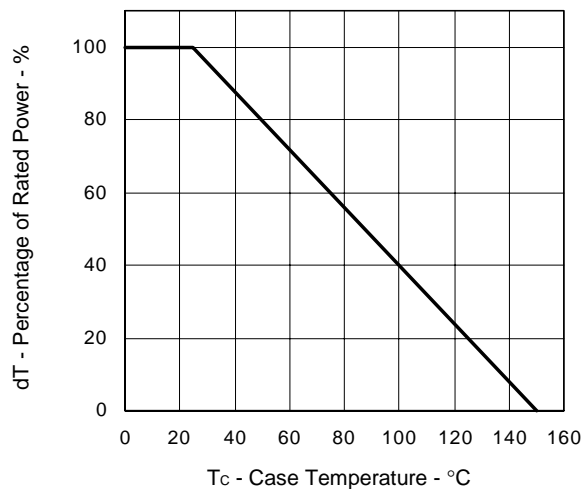


TEST CIRCUIT 3 GATE CHARGE

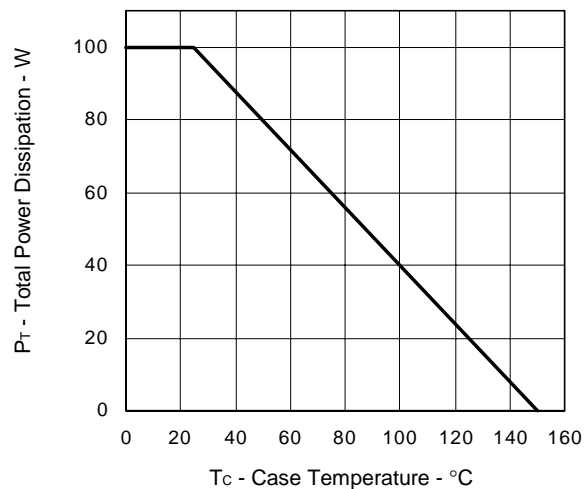


TYPICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$)

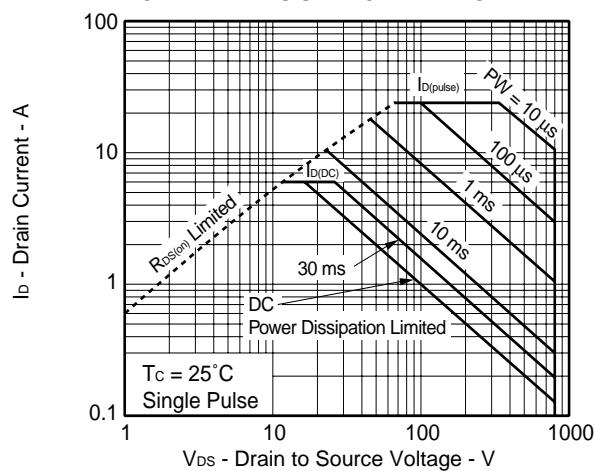
DERATING FACTOR OF FORWARD BIAS
SAFE OPERATING AREA



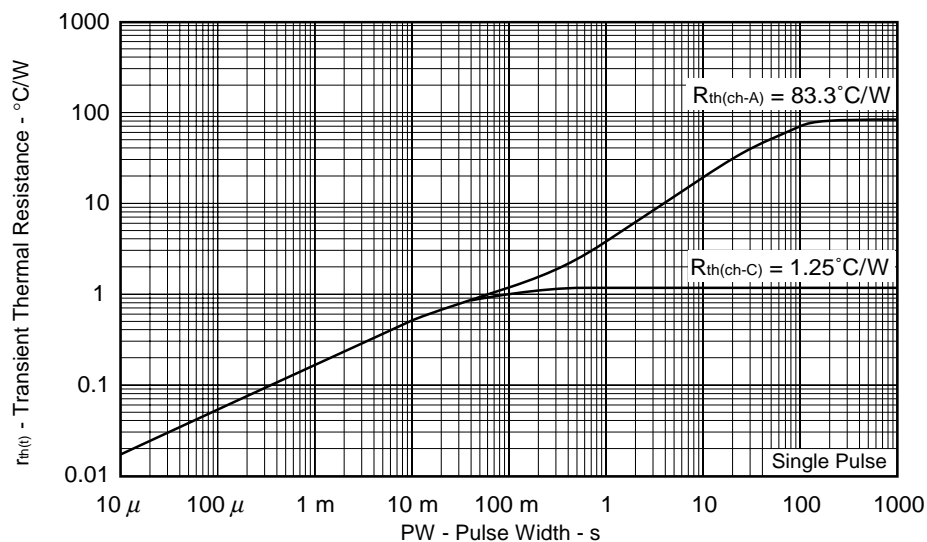
TOTAL POWER DISSIPATION vs.
CASE TEMPERATURE



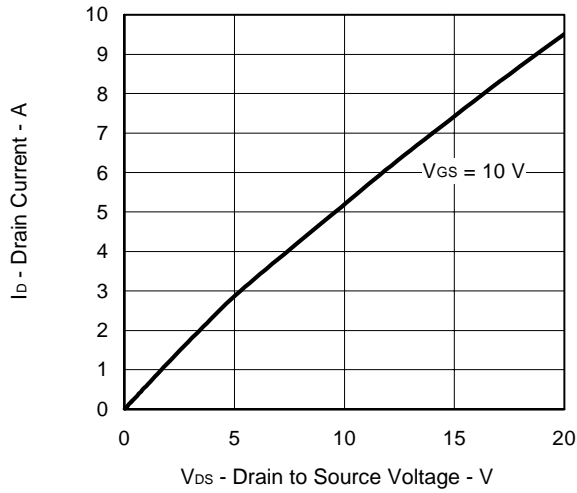
FORWARD BIAS SAFE OPERATING AREA



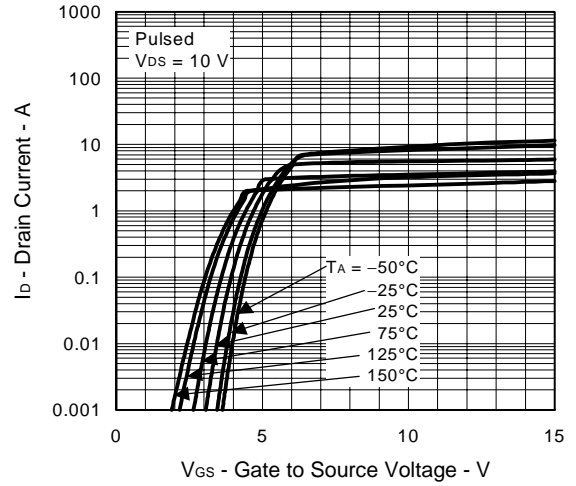
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



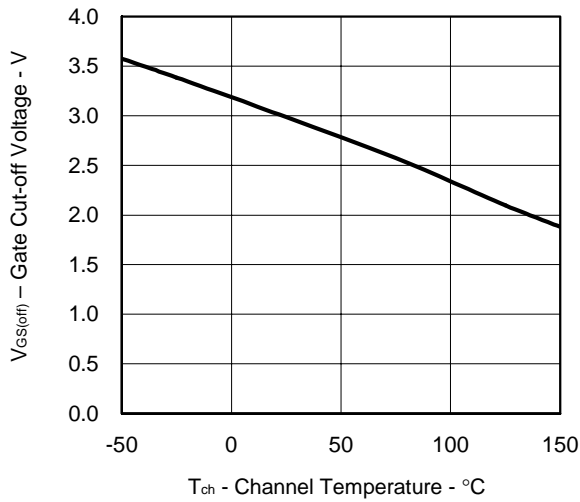
DRAIN CURRENT vs.
DRAIN TO SOURCE VOLTAGE



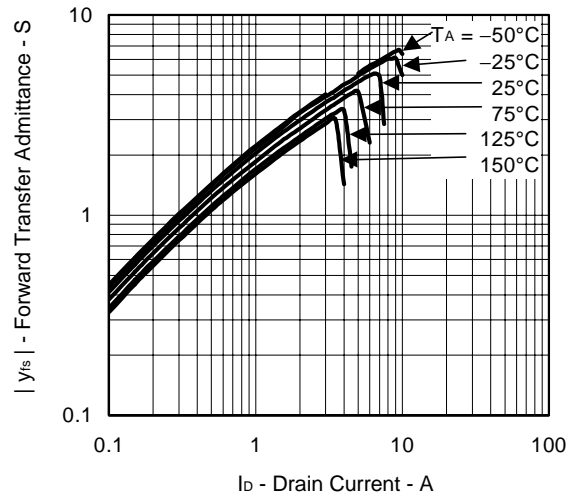
FORWARD TRANSFER CHARACTERISTICS



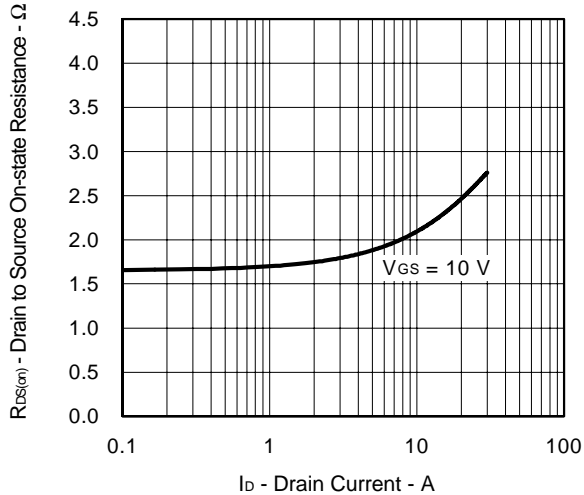
GATE CUT-OFF VOLTAGE vs.
CHANNEL TEMPERATURE



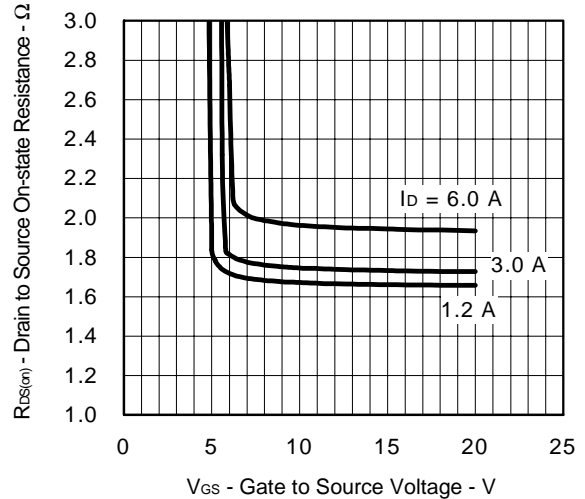
FORWARD TRANSFER ADMITTANCE vs.
DRAIN CURRENT



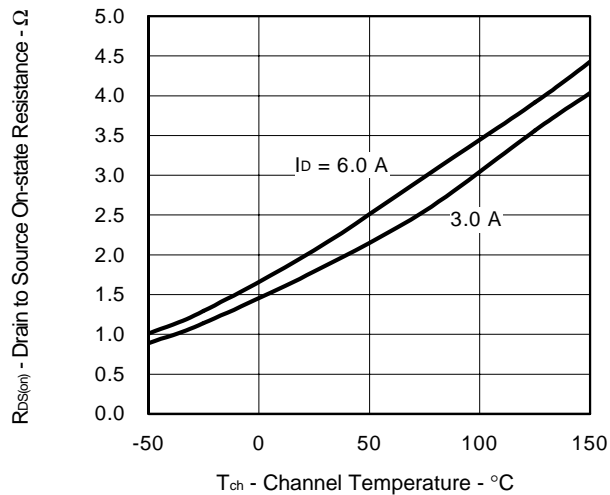
DRAIN TO SOURCE ON-STATE
RESISTANCE vs. DRAIN CURRENT



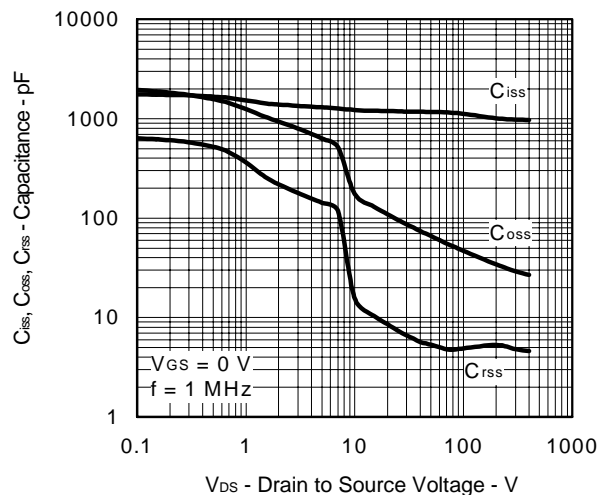
DRAIN TO SOURCE ON-STATE RESISTANCE vs.
GATE TO SOURCE VOLTAGE



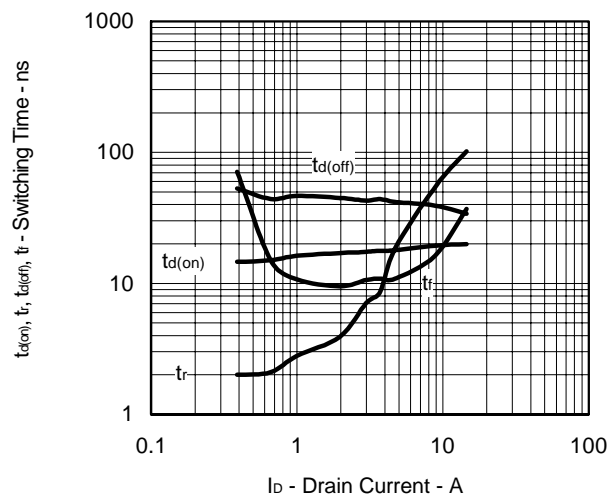
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



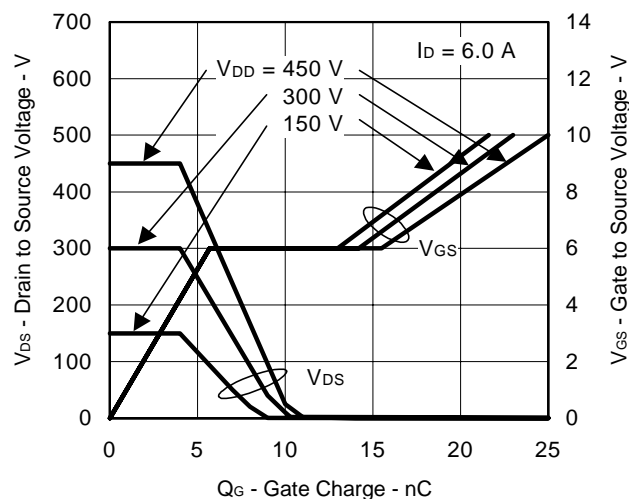
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



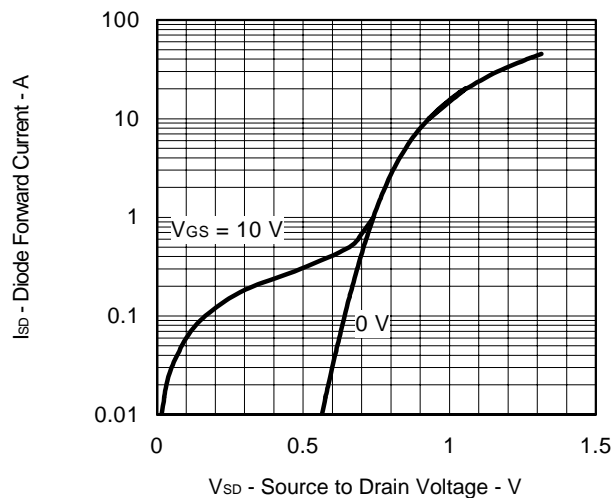
SWITCHING CHARACTERISTICS



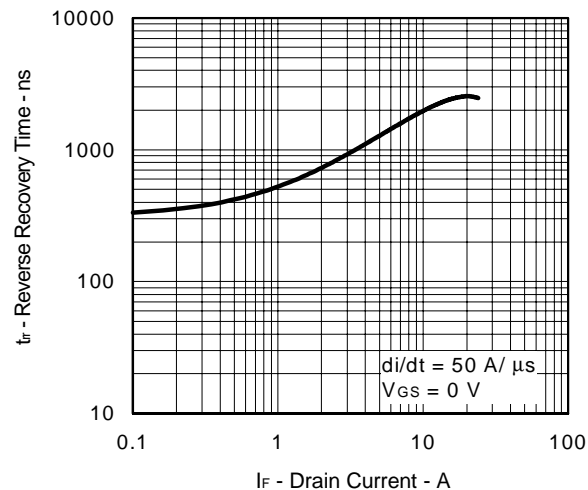
DYNAMIC INPUT/OUTPUT CHARACTERISTICS



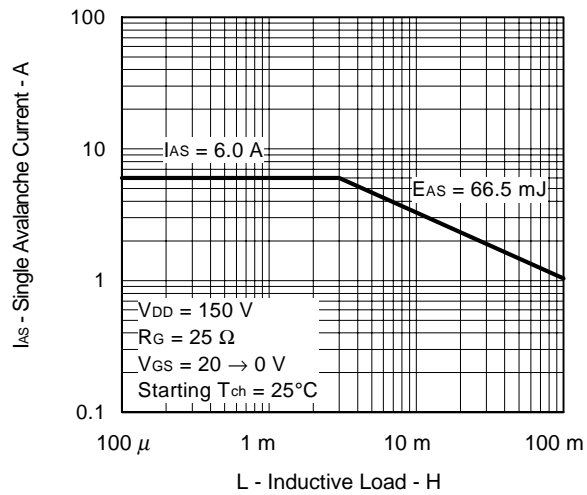
SOURCE TO DRAIN DIODE FORWARD VOLTAGE



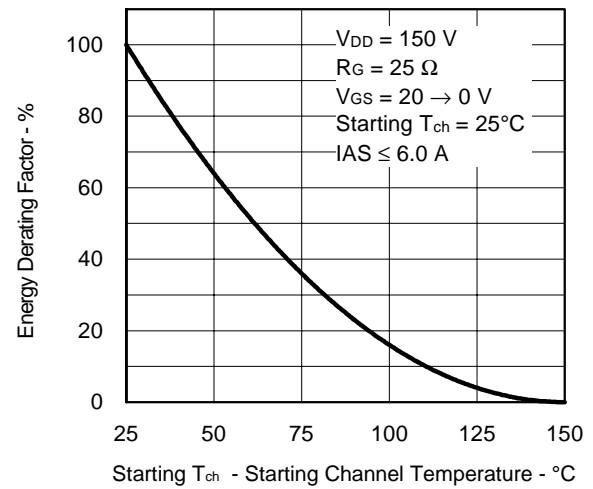
REVERSE RECOVERY TIME vs. DRAIN CURRENT



SINGLE AVALANCHE CURRENT vs.
INDUCTIVE LOAD

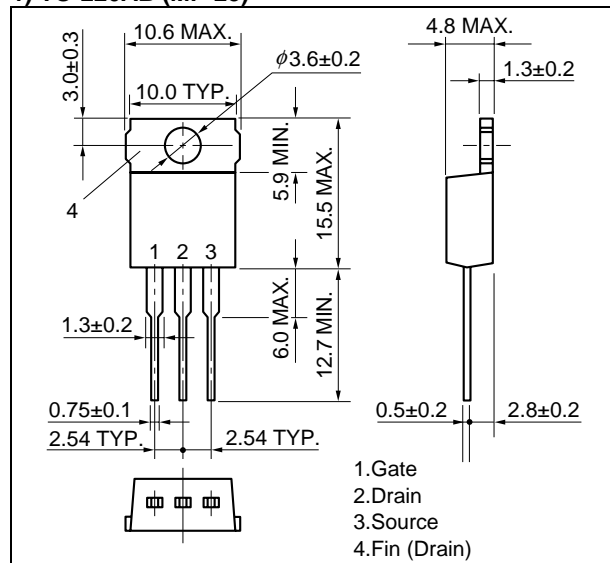


SINGLE AVALANCHE ENERGY
DERATING FACTOR

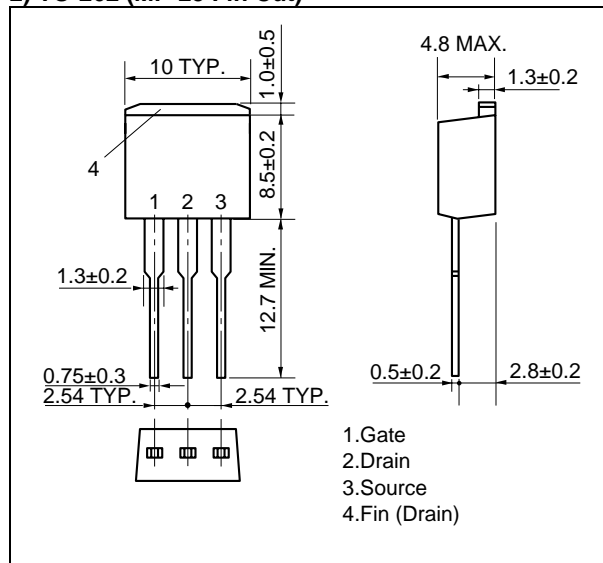


PACKAGE DRAWINGS (Unit: mm)

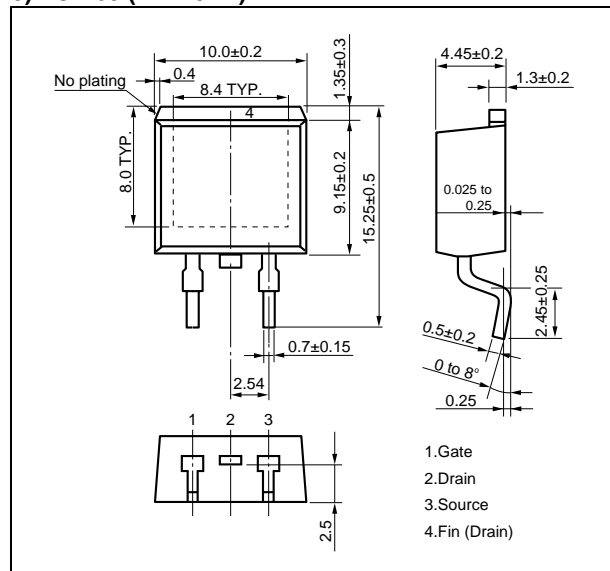
1) TO-220AB (MP-25)



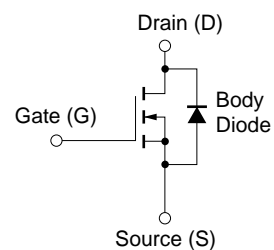
2) TO-262 (MP-25 Fin Cut)



3) TO-263 (MP-25ZK)



EQUIVALENT CIRCUIT



Remark Strong electric field, when exposed to this device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred.

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